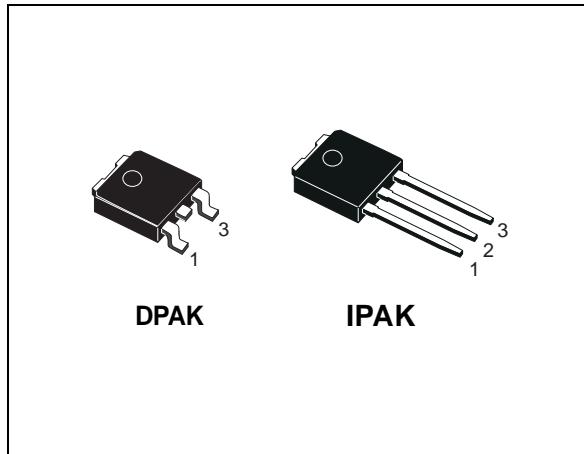


N-channel 24V - 0.0052Ω - 60A - DPAK - IPAK
STripFET™ III Power MOSFET

General features

Type	V _{DSS}	R _{DS(on)}	I _D
STD90N02L	24V	<0.006Ω	60A
STD90N02L-1	24V	<0.006Ω	60A

- R_{DS(ON)} * Qg industry's benchmark
- Conduction losses reduced
- Switching losses reduced
- Low threshold device
- In compliance with the 2002/95/ec european directive



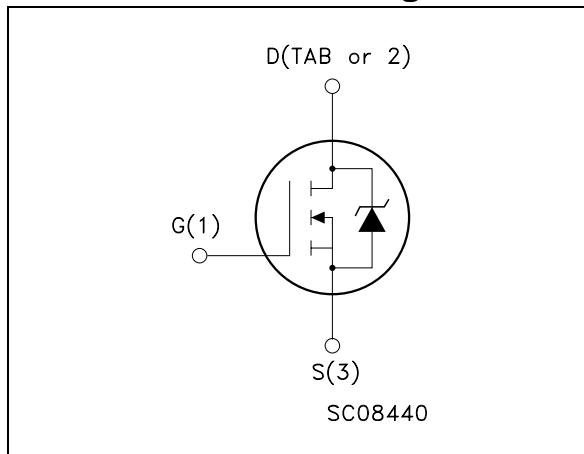
Description

This series of products utilizes the latest advanced design rules of ST's proprietary STripFET™ technology. This is suitable for the most demanding DC-DC converter application where high efficiency is to be achieved.

Applications

- Switching application

Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD90N02L-1	D90N02L	IPAK	Tube
STD90N02L	D90N02L	DPAK	Tape & reel

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
2.1	Electrical characteristics (curves)	6
3	Test circuits	11
4	Package mechanical data	12
5	Package mechanical data	15
6	Revision history	16

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{\text{spike}}^{(1)}$	Drain-source voltage rating	30	V
V_{DS}	Drain-source voltage ($V_{\text{GS}} = 0$)	24	V
V_{DGR}	Drain-gate voltage ($R_{\text{GS}} = 20\text{k}\Omega$)	24	V
V_{GS}	Gate-source voltage	± 20	V
$I_{\text{D}}^{(2)}$	Drain current (continuous) at $T_{\text{C}} = 25^{\circ}\text{C}$	60	A
I_{D}	Drain current (continuous) at $T_{\text{C}} = 100^{\circ}\text{C}$	42	A
$I_{\text{DM}}^{(3)}$	Drain current (pulsed)	240	A
P_{TOT}	Total dissipation at $T_{\text{C}} = 25^{\circ}\text{C}$	70	W
	Derating factor	0.47	W/ $^{\circ}\text{C}$
$E_{\text{AS}}^{(4)}$	Single pulse avalanche energy	360	mJ
T_{j} T_{stg}	Operating junction temperature Storage temperature	-55 to 175	$^{\circ}\text{C}$

1. Guaranteed when external $R_{\text{g}}=4.7\Omega$ and $T_f < T_{f\text{max}}$
2. Value limited by wire bonding
3. Pulse width limited by safe operating area
4. Starting $T_{\text{j}} = 25^{\circ}\text{C}$, $I_{\text{D}} = 30\text{A}$, $V_{\text{DD}} = 15\text{V}$

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{\text{thj-case}}$	Thermal resistance junction-case Max	2.14	$^{\circ}\text{C/W}$
$R_{\text{thj-amb}}$	Thermal resistance junction-amb Max	100	$^{\circ}\text{C/W}$
T_{l}	Maximum lead temperature for soldering purpose	275	$^{\circ}\text{C}$

2 Electrical characteristics

(T_{case} =25°C unless otherwise specified)

Table 3. On /off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 25mA, V _{GS} = 0	24			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 20V, V _{DS} = 20V, T _c = 125°C			1 10	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20V			±100	nA
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 250μA	1	1.8		V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 30A V _{GS} = 5V, I _D = 15A		0.0052 0.007	0.006 0.011	Ω Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} =10V, I _D = 18A		27		s
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =16V, f=1MHz, V _{GS} =0		2050 545 70		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} =10V, I _D = 60A V _{GS} =5V (see Figure 15)		17 7.7 3.5	22	nC nC nC
R _G	Gate input resistance	f=1MHz Gate DC Bias =0 test signal level =20mV open drain	0.5	1.5	3	Ω
Q _{OSS} ⁽²⁾	Output charge	V _{DS} =10V, V _{GS} =0V		14		nC

1. Pulsed: pulse duration = 300μs, duty cycle 1.5%
2. Q_{OSS}= C_{oss} * D Vin, C_{oss} = C_{gd} + C_{gd}. (see [Appendix A](#))

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max	Unit
$t_{d(on)}$	Turn-on delay time			12		ns
t_r	Rise time			200		ns
$t_{d(off)}$	Turn-off delay time	$V_{DD}=10V, I_D=30A,$ $R_G=4.7\Omega, V_{GS}=5V$ (see Figure 17)		18		ns
t_f	Fall time			25	33	ns

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current				60	A
I_{SDM}	Source-drain current (pulsed)				240	A
$V_{SD}^{(1)}$	Forward on voltage	$I_{SD}=30A, V_{GS}=0$			1.3	V
t_{rr}	Reverse recovery time	$I_{SD}=60A, di/dt = 100A/\mu s,$		36		ns
Q_{rr}	Reverse recovery charge	$V_{DD}=15V, T_j=150^\circ C$		65		nC
I_{RRM}	Reverse recovery current	(see Figure 20)		3.6		A

1. Pulsed: pulse duration = 300μs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

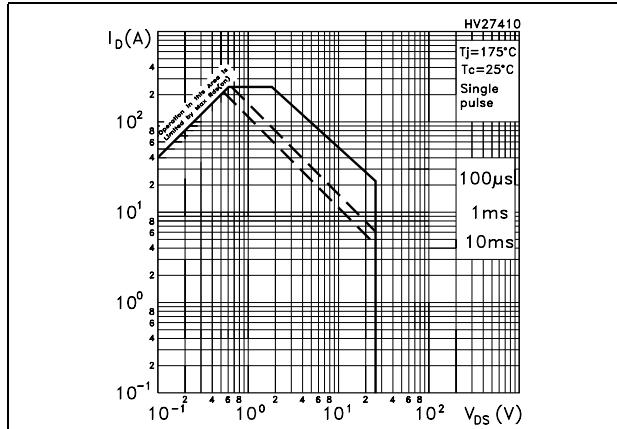


Figure 2. Thermal impedance

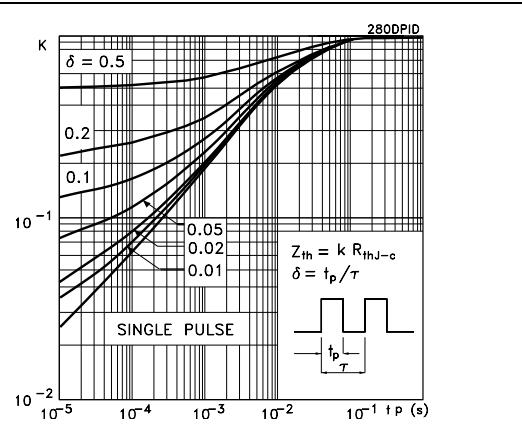


Figure 3. Output characteristics

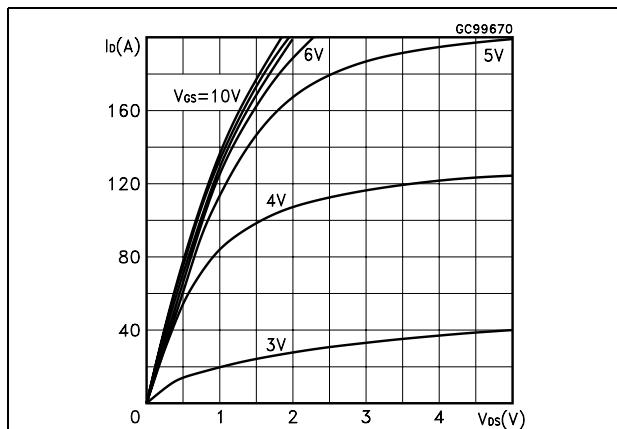


Figure 4. Transfer characteristics

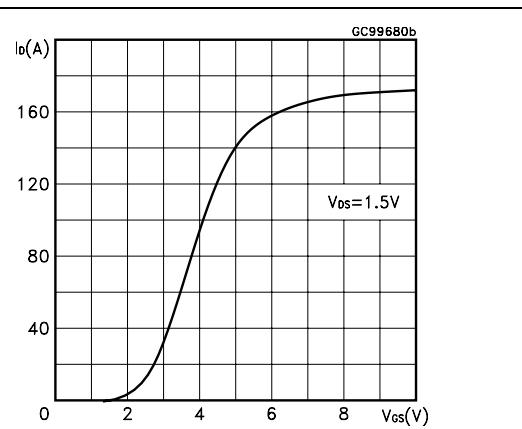


Figure 5. Transconductance

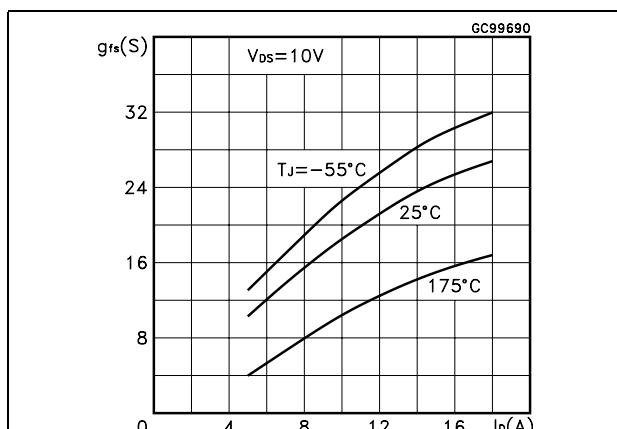


Figure 6. Static drain-source on resistance

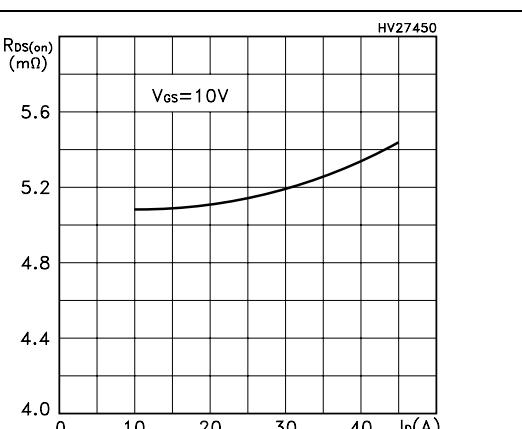


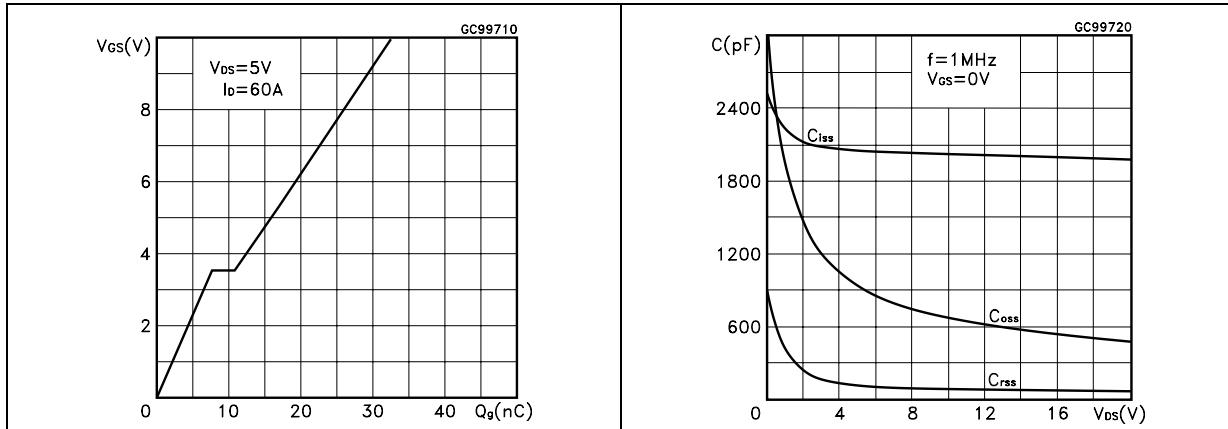
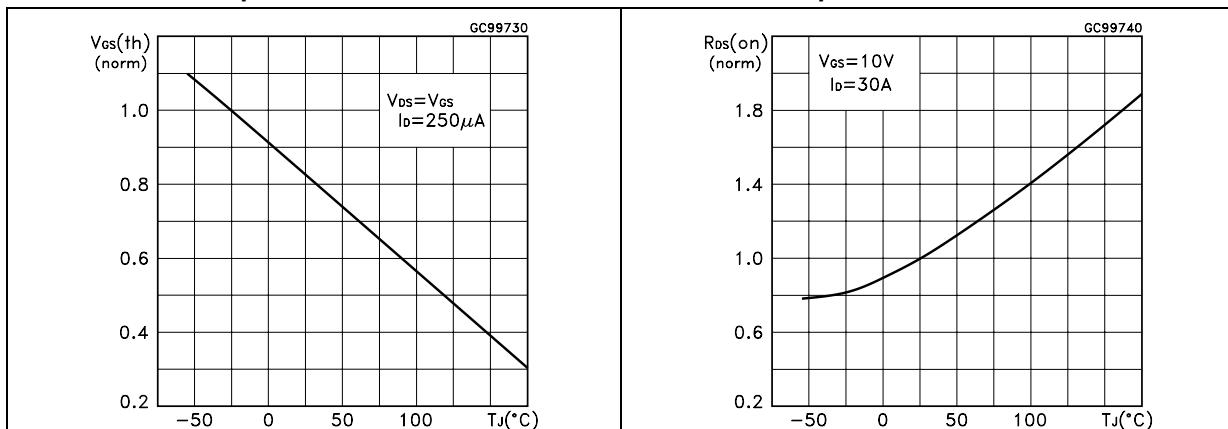
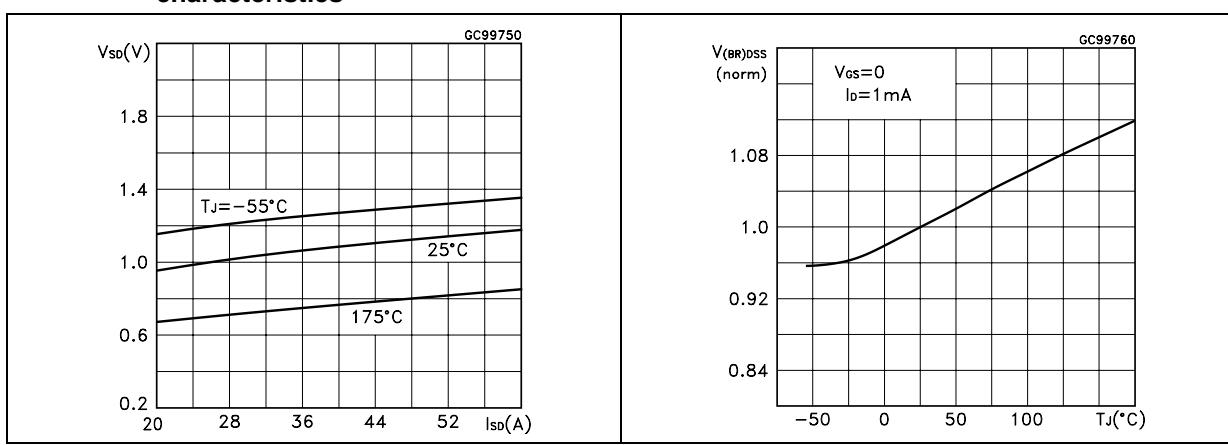
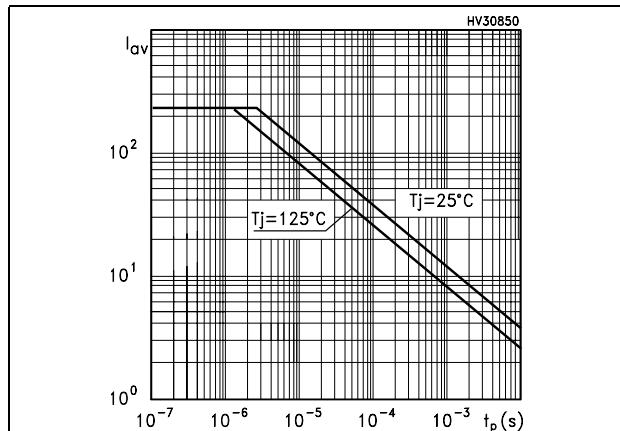
Figure 7. Gate charge vs gate-source voltage **Figure 8.** Capacitance variations**Figure 9.** Normalized gate threshold voltage vs temperature**Figure 10.** Normalized on resistance vs temperature**Figure 11.** Source-drain diode forward characteristics**Figure 12.** Normalized B_{VDSS} vs temperature

Figure 13. Allowable I_{AV} vs time in avalanche

The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

$$P_{D(AVE)} = 0.5 * (1.3 * B_{VDSS} * I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} * t_{AV}$$

Where:

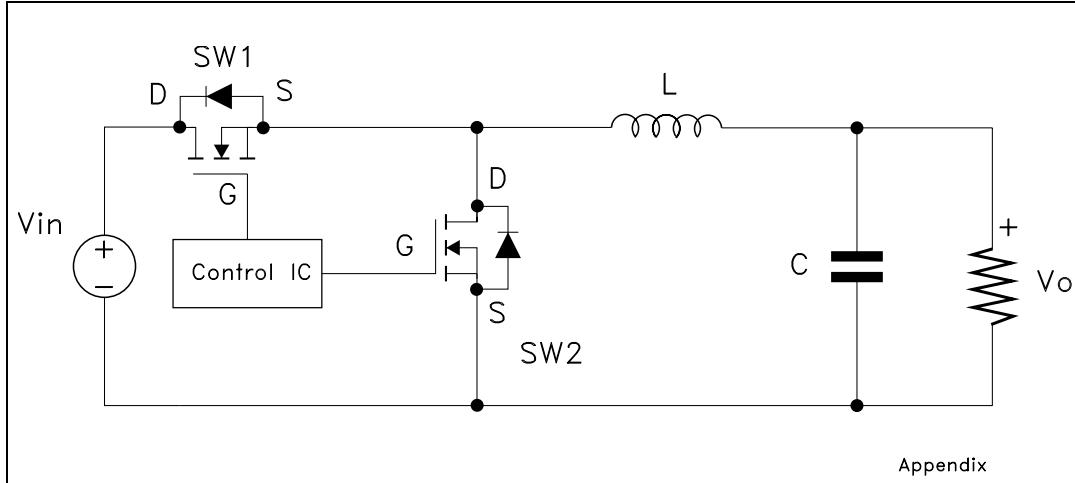
I_{AV} is the allowable current in avalanche

$P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

t_{AV} is the time in avalanche

Appendix A

Figure 14. Synchronous buck converter



The power losses associated with the FETs in a Synchronous Buck converter can be estimated using the equations shown in the table below. The formulas give a good approximation, for the sake of performance comparison, of how different pairs of devices affect the converter efficiency. However a very important parameter, the working temperature, is not considered. The real device behavior is really dependent on how the heat generated inside the devices is removed to allow for a safer working junction temperature.

The low side (SW2) device requires:

Very low RDS(on) to reduce conduction losses

Small Qgls to reduce the gate charge losses

Small Coss to reduce losses due to output capacitance

Small Qrr to reduce losses on SW1 during its turn-on

The Cgd/Cgs ratio lower than Vth/Vgg ratio especially with low drain to source voltage to avoid the cross conduction phenomenon.

The high side (SW1) device requires:

Small Rg and Lg to allow higher gate current peak and to limit the voltage feedback on the gate

Small Qg to have a faster commutation and to reduce gate charge losses

Low RDS(on) to reduce the conduction losses

Table 7. Power losses

		High side switch (SW1)	Low side switch (SW2)
$P_{\text{conduction}}$		$R_{DS(\text{on})} \cdot I_L^2 \cdot \delta$	$R_{DS(\text{on})} \cdot I_L^2 \cdot (1 - \delta)$
$P_{\text{switching}}$		$V_{in} \cdot (Q_{gsth(SW1)} + Q_{gd(SW1)}) \cdot f \cdot \frac{I_L}{I_g}$	Zero voltage switching
P_{diode}	recovery	Not applicable	$V_{in} \cdot Q_{rr(SW2)} \cdot f$
	conduction	Not applicable	$V_{f(SW2)} \cdot I_L \cdot t_{\text{deadtime}} \cdot f$
$P_{\text{gate}(Qg)}$		$Q_{g(SW1)} \cdot V_{gg} \cdot f$	$Q_{gl(SW2)} \cdot V_{gg} \cdot f$
P_{Qoss}		$\frac{V_{in} \cdot Q_{oss(SW1)} \cdot f}{2}$	$\frac{V_{in} \cdot Q_{oss(SW2)} \cdot f}{2}$

Table 8. Power losses parameters

Paramter	Meaning
d	Duty-cycle
Q_{gsth}	Post threshold gate charge
Q_{gl}	Third quadrant gate charge
$P_{\text{conduction}}$	On state losses
$P_{\text{switching}}$	On-off transition losses
P_{diode}	Conduction and reverse recovery diode losses
P_{gate}	Gate driver losses
P_{Qoss}	Output capacitance losses

3 Test circuits

Figure 15. Switching times test circuit for resistive load

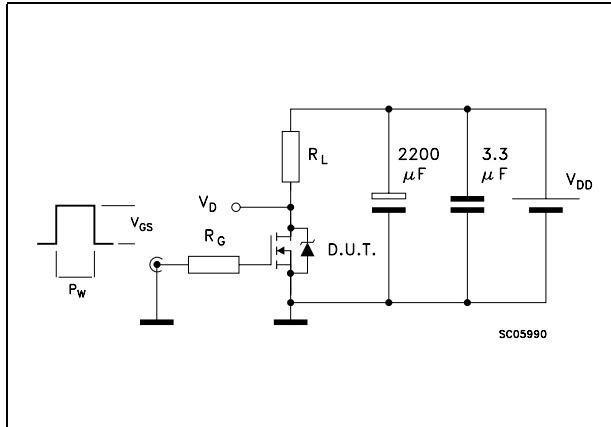


Figure 16. Gate charge test circuit

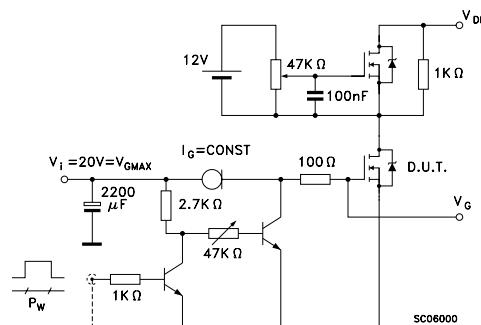


Figure 17. Test circuit for inductive load switching and diode recovery times

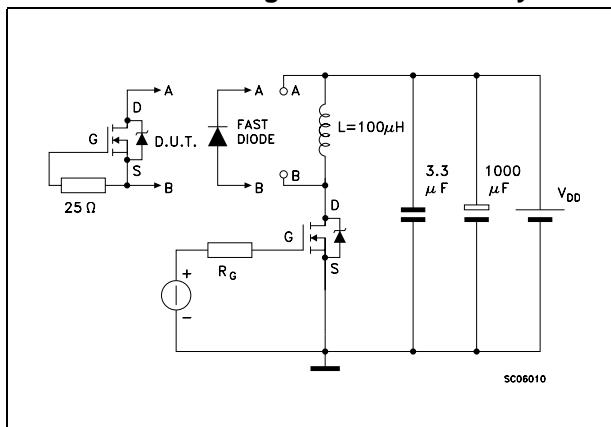


Figure 18. Unclamped inductive load test circuit

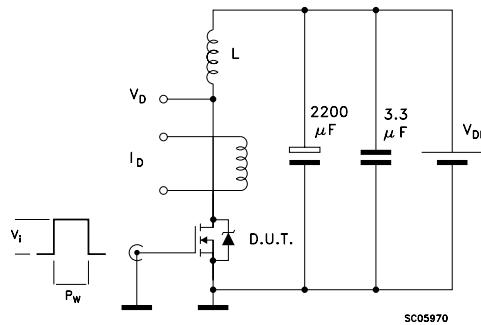


Figure 19. Unclamped inductive waveform

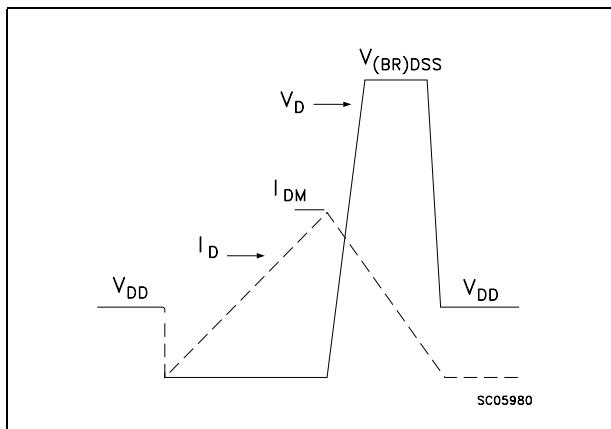
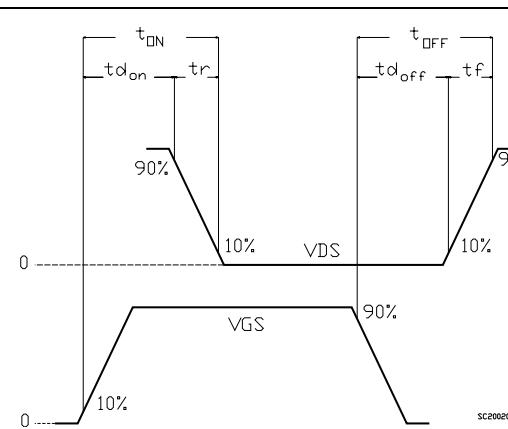


Figure 20. Switching time waveform

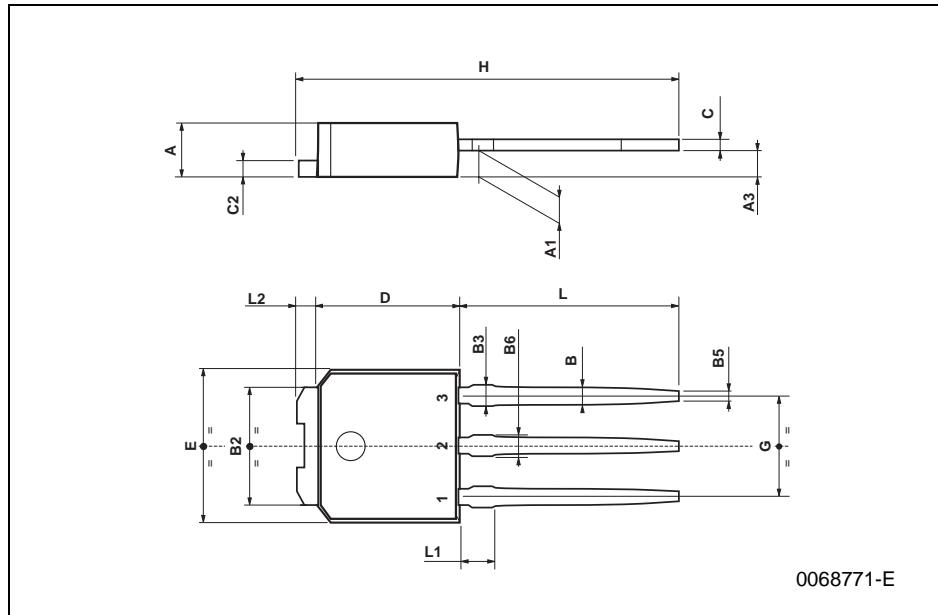


4 Package mechanical data

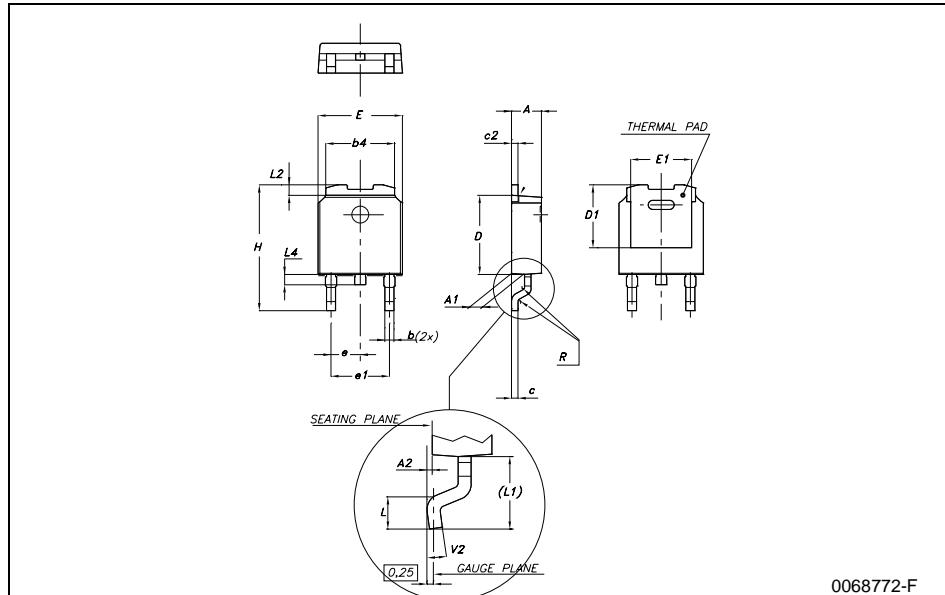
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at :www.st.com

TO-251 (IPAK) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
B	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
H	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



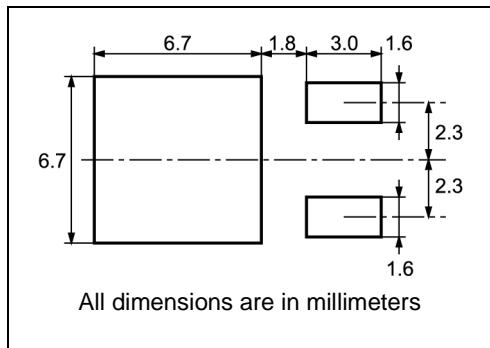
DPAK MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
B	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
e		2.28			0.090	
e1	4.4		4.6	0.173		0.181
H	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°



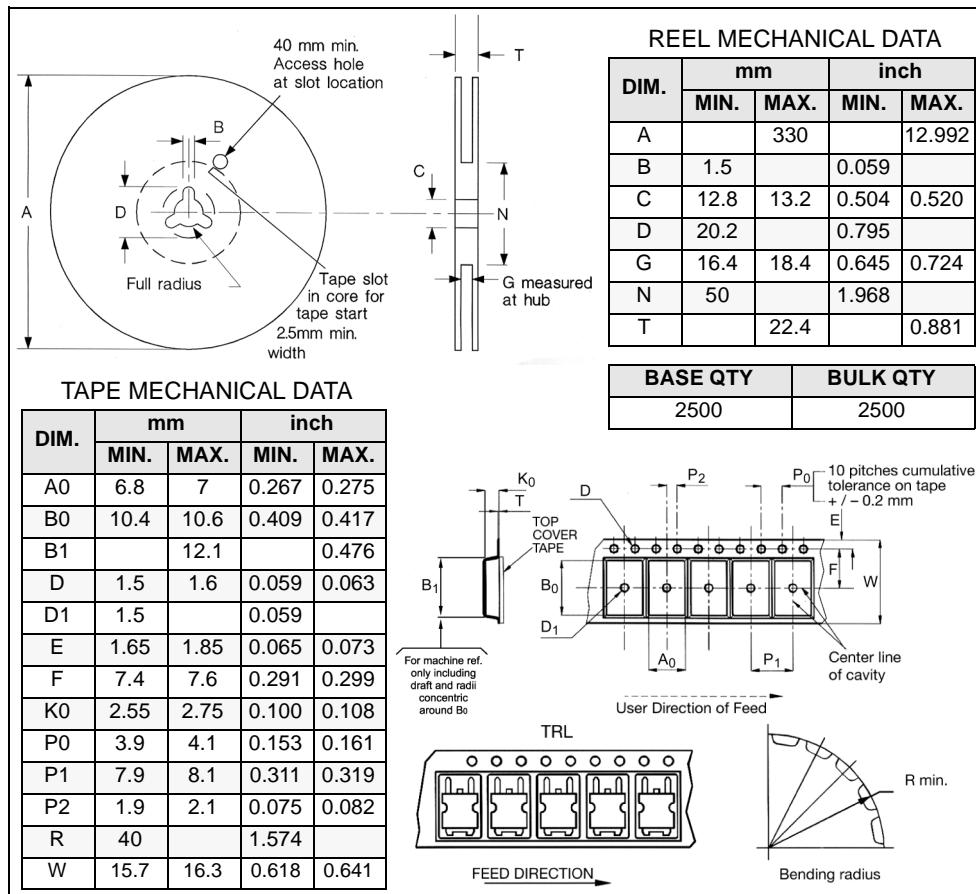
0068772-F

5 Package mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



6 Revision history

Table 9. Revision history

Date	Revision	Changes
29-Aug-2005	1	First release
07-Apr-2006	2	New template
03-May-2006	3	New value on Table 3 , new curve (see Figure 13)

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZE REPRESENTATIVE OF ST, ST PRODUCTS ARE NOT DESIGNED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS, WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2006 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

